

$V_{DRM}$	=	4500 V
$I_{TGQM}$	=	4000 A
$I_{TSM}$	=	$25 \times 10^3$ A
$V_{T0}$	=	1.2 V
$r_T$	=	0.65 mW
$V_{Dclink}$	=	2800 V

# Asymmetric Gate turn-off Thyristor 5SGF 40L4502

Doc. No. 5SYA1209-04 Feb. 05

- Patented free-floating silicon technology
- Low on-state and switching losses
- Annular gate electrode
- Industry standard housing
- Cosmic radiation withstand rating

## Blocking

*Maximum rated values <sup>1)</sup>*

Parameter	Symbol	Conditions	min	typ	max	Unit
Repetitive peak off-state voltage	$V_{DRM}$	$V_{GR} \geq 2$ V			4500	V
Repetitive peak reverse voltage	$V_{RRM}$				17	V
Permanent DC voltage for 100 FIT failure rate	$V_{Dclink}$	Ambient cosmic radiation at sea level in open air.			2800	V

*Characteristic values*

Parameter	Symbol	Conditions	min	typ	max	Unit
Repetitive peak off-state current	$I_{DRM}$	$V_D = V_{DRM}, V_{GR} \geq 2$ V			100	mA
Repetitive peak reverse current	$I_{RRM}$	$V_R = V_{RRM}, R_{GK} = \infty \Omega$			50	mA

## Mechanical data

*Maximum rated values <sup>1)</sup>*

Parameter	Symbol	Conditions	min	typ	max	Unit
Mounting force	$F_m$		36	40	44	kN

*Characteristic values*

Parameter	Symbol	Conditions	min	typ	max	Unit
Pole-piece diameter	$D_p$	$\pm 0.1$ mm		75		mm
Housing thickness	H		26.0		26.5	mm
Weight	m				1.5	kg
Surface creepage distance	$D_s$	Anode to Gate	33			mm
Air strike distance	$D_a$	Anode to Gate	14			mm

1) Maximum rated values indicate limits beyond which damage to the device may occur

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## GTO Data

### On-state

Maximum rated values <sup>1)</sup>

Parameter	Symbol	Conditions	min	typ	max	Unit
Max. average on-state current	$I_{T(AV)M}$	Half sine wave, $T_C = 85^\circ\text{C}$			1180	A
Max. RMS on-state current	$I_{T(RMS)}$				1850	A
Max. peak non-repetitive surge current	$I_{TSM}$	$t_p = 10\text{ ms}$ , $T_{vj} = 125^\circ\text{C}$ , sine wave After Surge: $V_D = V_R = 0\text{ V}$			$25 \times 10^3$	A
Limiting load integral	$I^2t$				$3.1 \times 10^6$	$\text{A}^2\text{s}$
Max. peak non-repetitive surge current	$I_{TSM}$	$t_p = 1\text{ ms}$ , $T_{vj} = 125^\circ\text{C}$ , sine wave After Surge: $V_D = V_R = 0\text{ V}$			$40 \times 10^3$	A
Limiting load integral	$I^2t$				$800 \times 10^3$	$\text{A}^2\text{s}$

Characteristic values

Parameter	Symbol	Conditions	min	typ	max	Unit
On-state voltage	$V_T$	$I_T = 4000\text{ A}$ , $T_{vj} = 125^\circ\text{C}$			3.8	V
Threshold voltage	$V_{(T0)}$	$T_{vj} = 125^\circ\text{C}$ $I_T = 400 \dots 5000\text{ A}$			1.2	V
Slope resistance	$r_T$				0.65	$\text{m}\Omega$
Holding current	$I_H$	$T_{vj} = 25^\circ\text{C}$			100	A

### Turn-on switching

Maximum rated values <sup>1)</sup>

Parameter	Symbol	Conditions	min	typ	max	Unit
Critical rate of rise of on-state current	$di_T/dt_{cr}$	$T_{vj} = 125^\circ\text{C}$ , $f = 200\text{ Hz}$ $I_T = 4000\text{ A}$ , $I_{GM} = 50\text{ A}$ , $di_G/dt = 40\text{ A}/\mu\text{s}$ , $f = 1\text{ Hz}$			500	$\text{A}/\mu\text{s}$
Critical rate of rise of on-state current	$di_T/dt_{cr}$				1000	$\text{A}/\mu\text{s}$
Min. on-time	$t_{on}$		100			$\mu\text{s}$

Characteristic values

Parameter	Symbol	Conditions	min	typ	max	Unit
Turn-on delay time	$t_d$	$V_D = 0.5 V_{DRM}$ , $T_{vj} = 125^\circ\text{C}$ $I_T = 4000\text{ A}$ , $di/dt = 300\text{ A}/\mu\text{s}$ , $I_{GM} = 50\text{ A}$ , $di_G/dt = 40\text{ A}/\mu\text{s}$ , $C_S = 6\text{ }\mu\text{F}$ , $R_S = 5\text{ }\Omega$			2.5	$\mu\text{s}$
Rise time	$t_r$				5	$\mu\text{s}$
Turn-on energy per pulse	$E_{on}$				3	J

### Turn-off switching

Maximum rated values <sup>1)</sup>

Parameter	Symbol	Conditions	min	typ	max	Unit
Max. controllable turn-off current	$I_{TGQM}$	$V_{DM} \leq V_{DRM}$ , $di_{GQ}/dt = 40\text{ A}/\mu\text{s}$ , $C_S = 6\text{ }\mu\text{F}$ , $L_S \leq 0.2\text{ }\mu\text{H}$			4000	A
Min. off-time	$t_{off}$		100			$\mu\text{s}$

Characteristic values

Parameter	Symbol	Conditions	min	typ	max	Unit
Storage time	$t_s$	$V_D = 0.5 V_{DRM}$ , $T_{vj} = 125^\circ\text{C}$ $V_{DM} \leq V_{DRM}$ , $di_{GQ}/dt = 40\text{ A}/\mu\text{s}$ , $I_{TGQ} = I_{TGQM}$ , $R_S = 5\text{ }\Omega$ , $C_S = 6\text{ }\mu\text{F}$ , $L_S = 0.2\text{ }\mu\text{H}$			25	$\mu\text{s}$
Fall time	$t_f$				3	$\mu\text{s}$
Turn-on energy per pulse	$E_{off}$				10	J
Peak turn-off gate current	$I_{GQM}$				1100	A

## Gate

Maximum rated values <sup>1)</sup>

Parameter	Symbol	Conditions	min	typ	max	Unit
Repetitive peak reverse voltage	V <sub>GRM</sub>				17	V
Repetitive peak reverse current	I <sub>GRM</sub>	V <sub>GR</sub> = V <sub>GRM</sub>			20	mA

Characteristic values

Parameter	Symbol	Conditions	min	typ	max	Unit
Gate trigger voltage	V <sub>GT</sub>	T <sub>vj</sub> = 25°C,		1.2		V
Gate trigger current	I <sub>GT</sub>	V <sub>D</sub> = 24 V, R <sub>A</sub> = 0.1 Ω		4		A

## Thermal

Maximum rated values <sup>1)</sup>

Parameter	Symbol	Conditions	min	typ	max	Unit
Junction operating temperature	T <sub>vj</sub>		-40		125	°C
Storage temperature range	T <sub>stg</sub>		-40		125	°C

Characteristic values

Parameter	Symbol	Conditions	min	typ	max	Unit
Thermal resistance junction to case	R <sub>th(jc)</sub>	Double side cooled			11	K/kW
	R <sub>th(jc)A</sub>	Anode side cooled			20	K/kW
	R <sub>th(jc)C</sub>	Cathode side cooled			25	K/kW
Thermal resistance case to heatsink (Double side cooled)	R <sub>th(ch)</sub>	Single side cooled			6	K/kW
	R <sub>th(ch)</sub>	Double side cooled			3	K/kW

Analytical function for transient thermal impedance:

$$Z_{thJC}(t) = \sum_{i=1}^n R_i(1 - e^{-t/\tau_i})$$

i	1	2	3	4
R <sub>i</sub> (K/kW)	7.766	1.728	1.064	0.450
τ <sub>i</sub> (s)	0.5764	0.1258	0.0128	0.0031

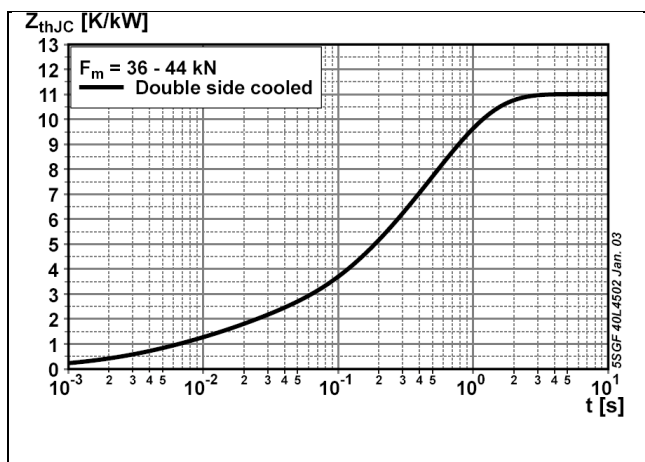


Fig. 1 Transient thermal impedance, junction to case.

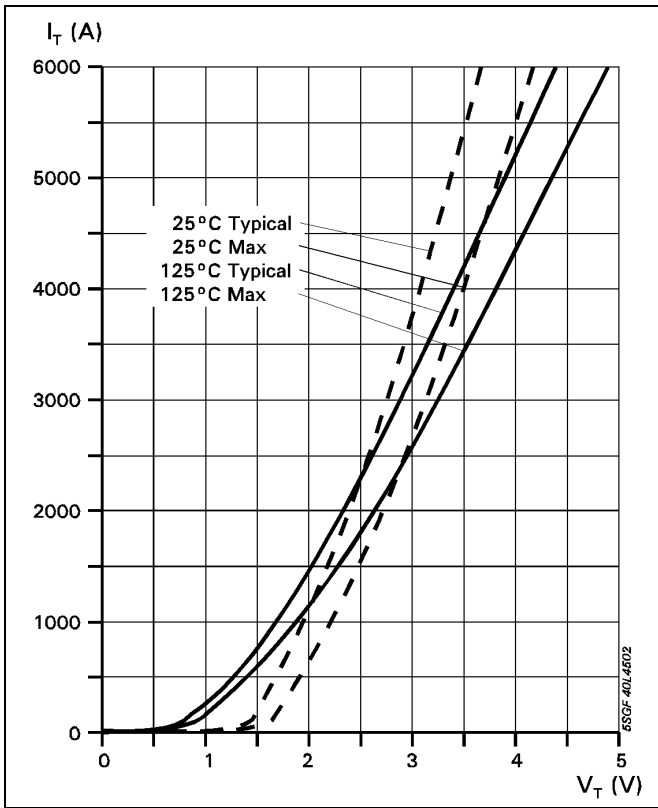


Fig. 2 On-state characteristics.

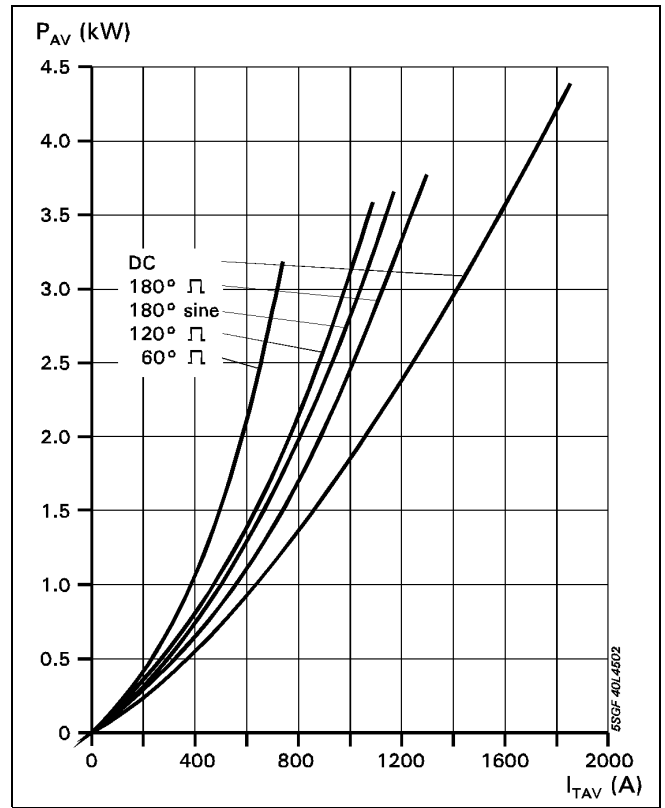


Fig. 3 Average on-state power dissipation vs. average on-state current.

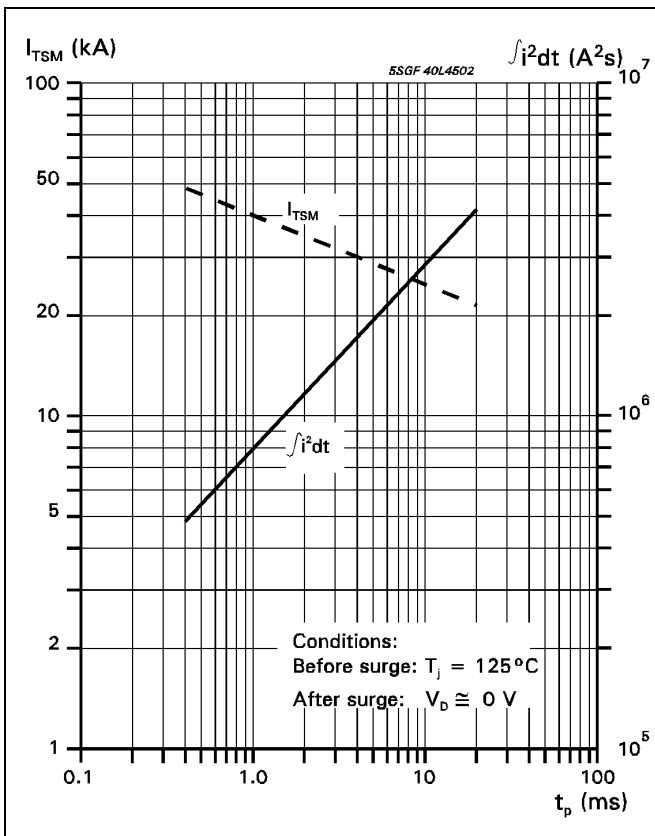


Fig. 4 Surge current and fusing integral vs. pulse width.

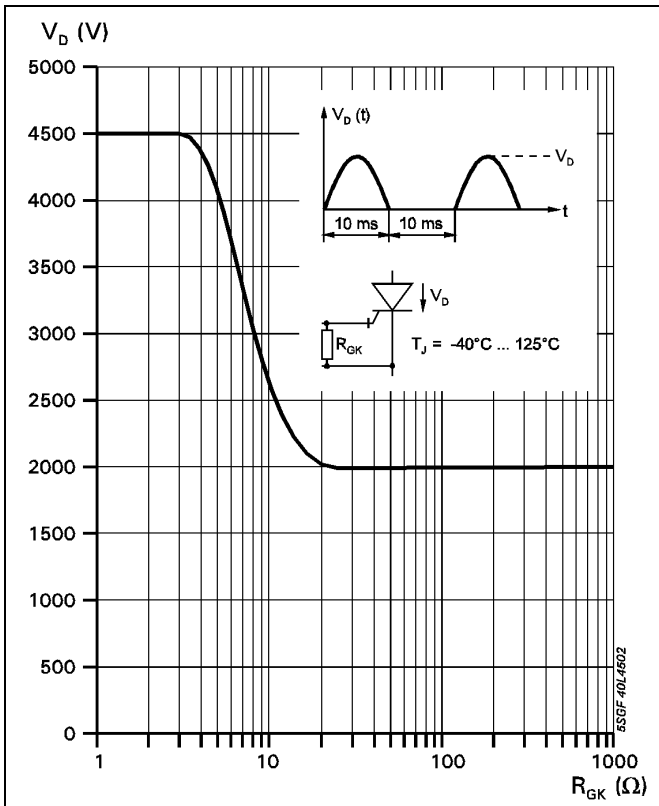


Fig. 5 Forward blocking voltage vs. gate-cathode resistance.

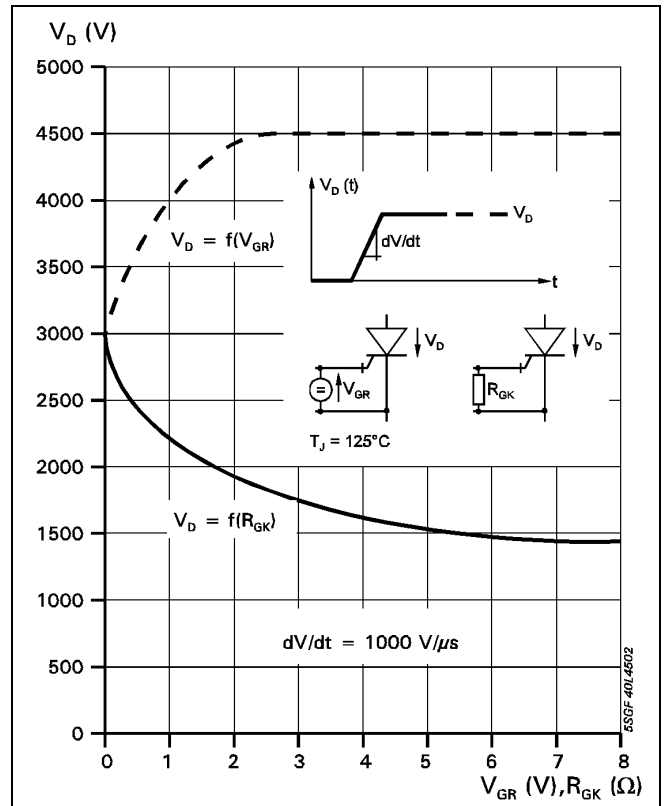


Fig. 6 Static dv/dt capability: Forward blocking voltage vs. neg. gate voltage or gate cathode resistance.

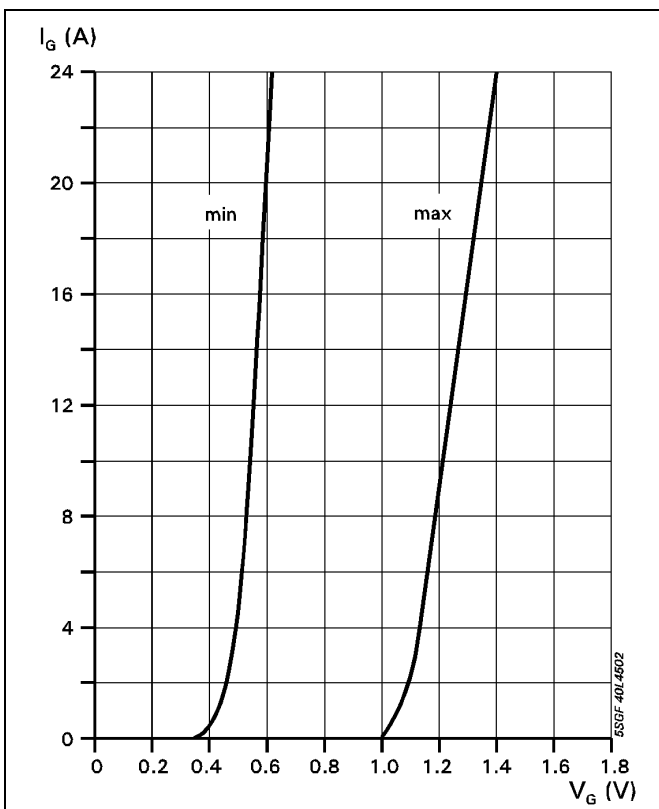


Fig. 7 Forward gate current vs. forward gate voltage.

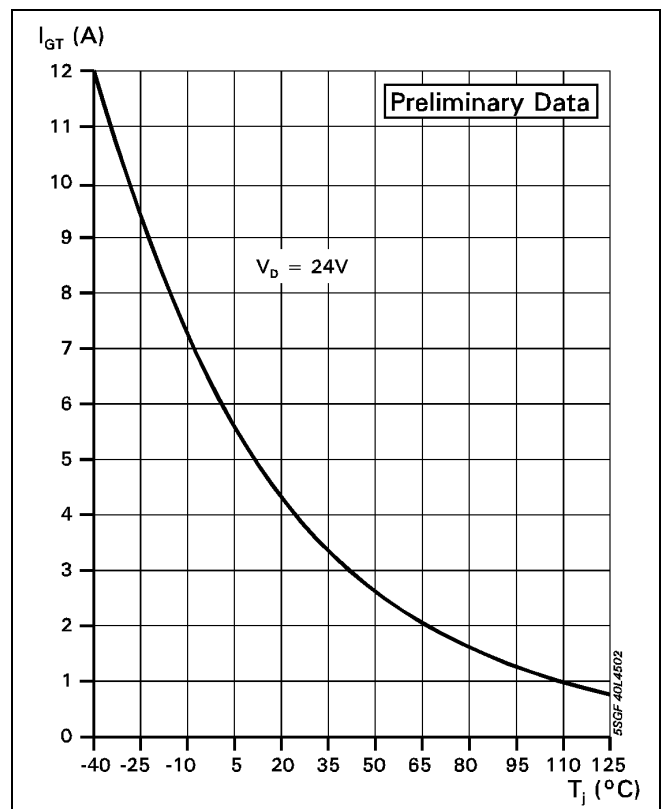
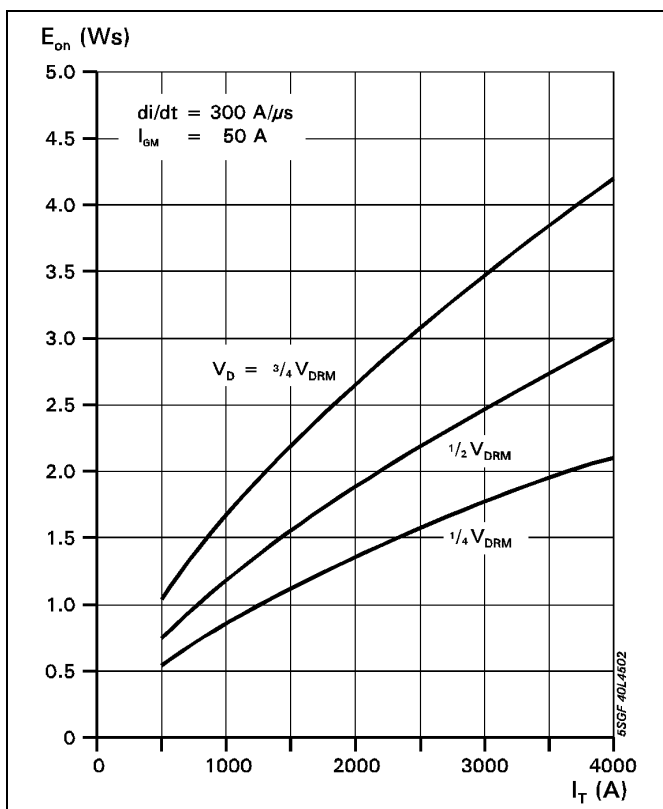
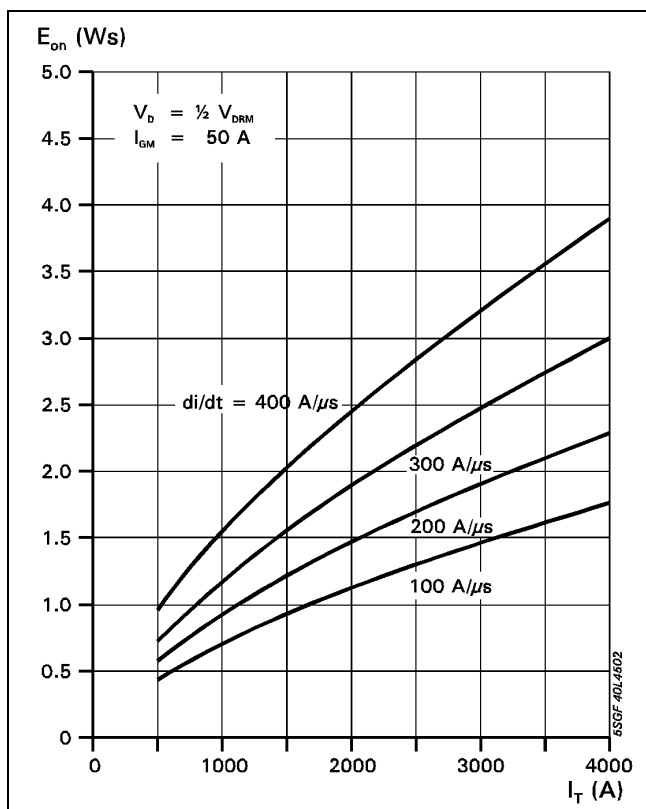


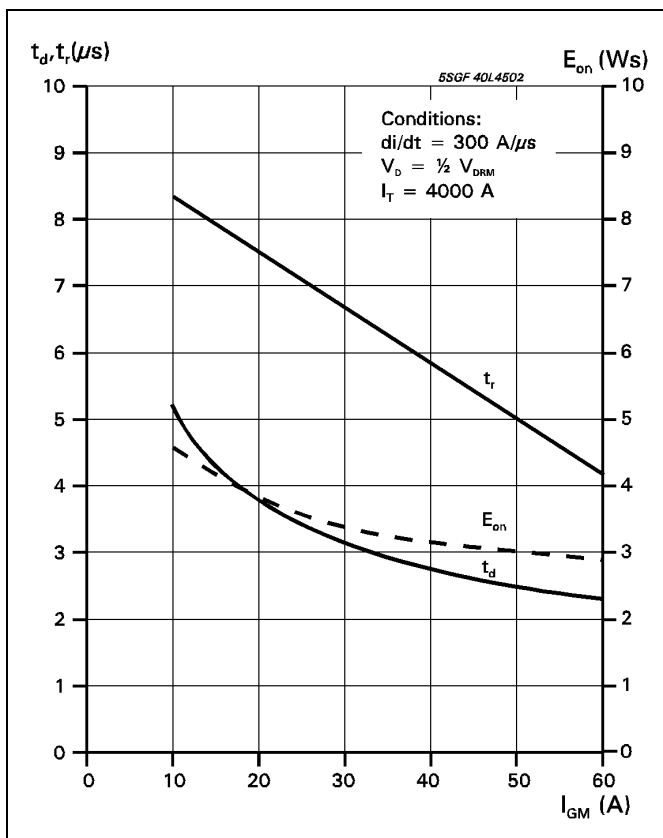
Fig. 8 Gate trigger current vs. junction temperature



**Fig. 9** Turn-on energy per pulse vs. on-state current and turn-on voltage.



**Fig. 10** Turn-on energy per pulse vs. on-state current and current rise rate



**Fig. 11** Turn-on energy per pulse vs. on-state current and turn-on voltage.

Common Test conditions for figures 9, 10 and 11:

- $di_G/dt = 40 \text{ A}/\mu\text{s}$
- $C_S = 6 \mu\text{F}$
- $R_S = 5 \Omega$
- $T_j = 125 \text{ }^\circ\text{C}$

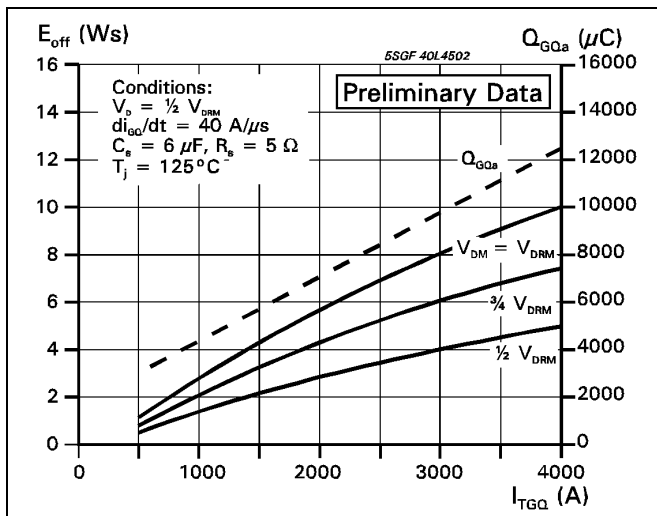
Definition of Turn-on energy:

$$E_{on} = \int_0^{20 \text{ ms}} V_D \cdot I_T dt \quad (t = 0, I_G = 0.1 \cdot I_{GM})$$

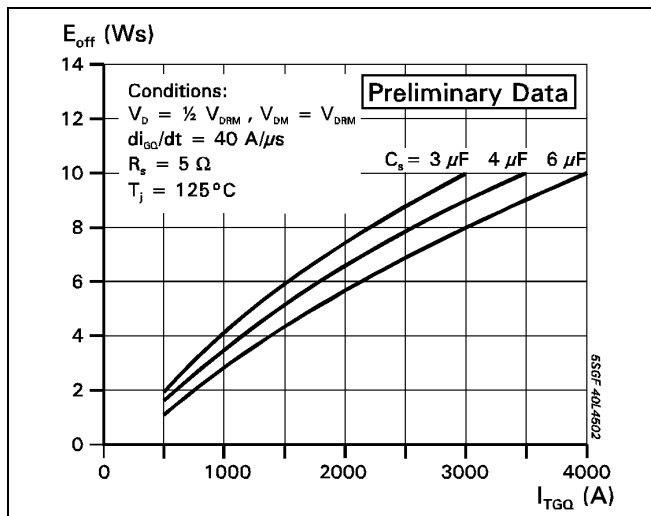
Common Test conditions for figures 12, 13 and 15:

Definition of Turn-off energy:

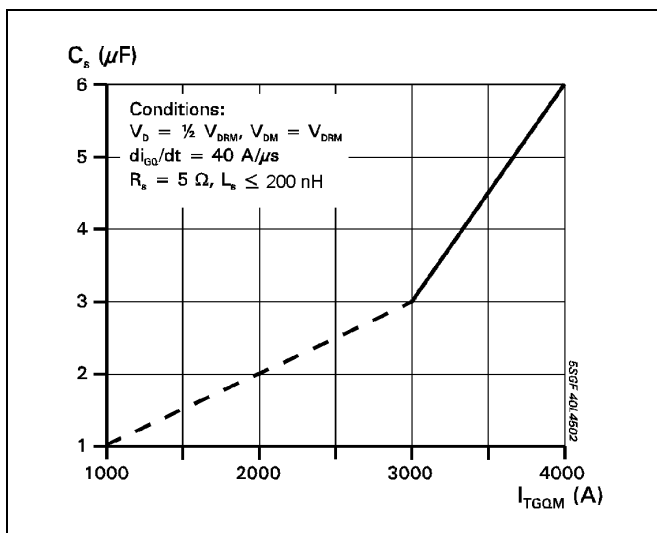
$$E_{off} = \int_0^{40 \text{ ms}} V_D \cdot I_T dt \quad (t = 0, I_T = 0.9 \cdot I_{TQ})$$



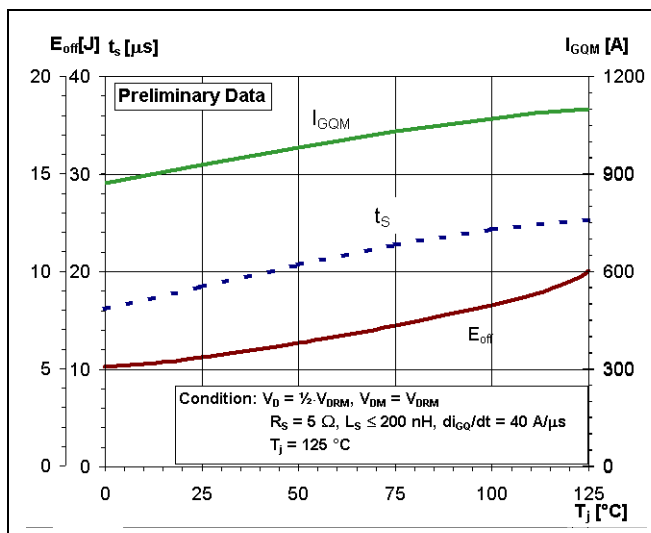
**Fig. 12** Turn-off energy per pulse vs. turn-off current and peak turn-off voltage. Extracted gate charge vs. turn-off current.



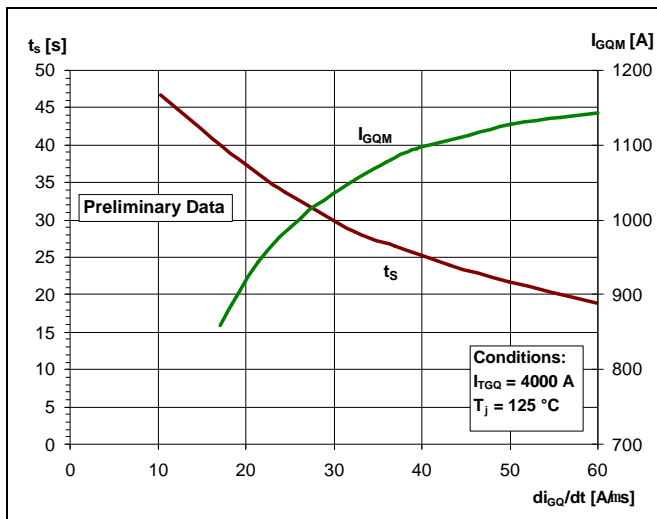
**Fig. 13** Turn-off energy per pulse vs. turn-off current and snubber capacitance.



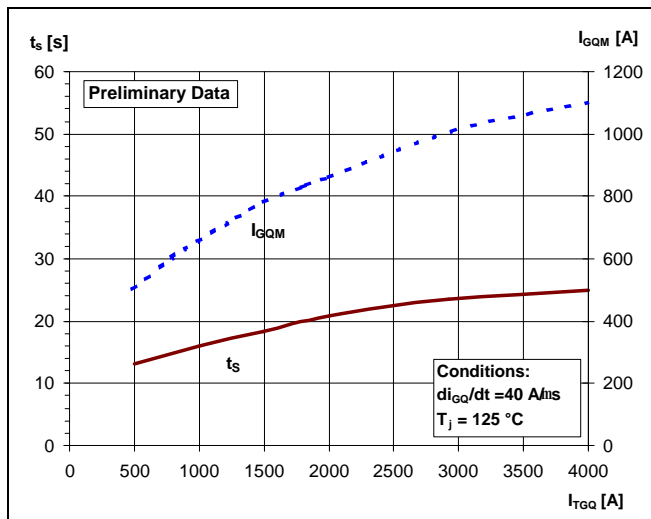
**Fig. 14** Required snubber capacitor vs. max allowable turn-off current.



**Fig. 15** Turn-off energy per pulse, storage time and peak turn-off gate current vs. junction temperature.



**Fig. 16** Storage time and peak turn-off gate current vs. neg. gate current rise rate.



**Fig. 17** Storage time and peak turn-off gate current vs. turn-off current.

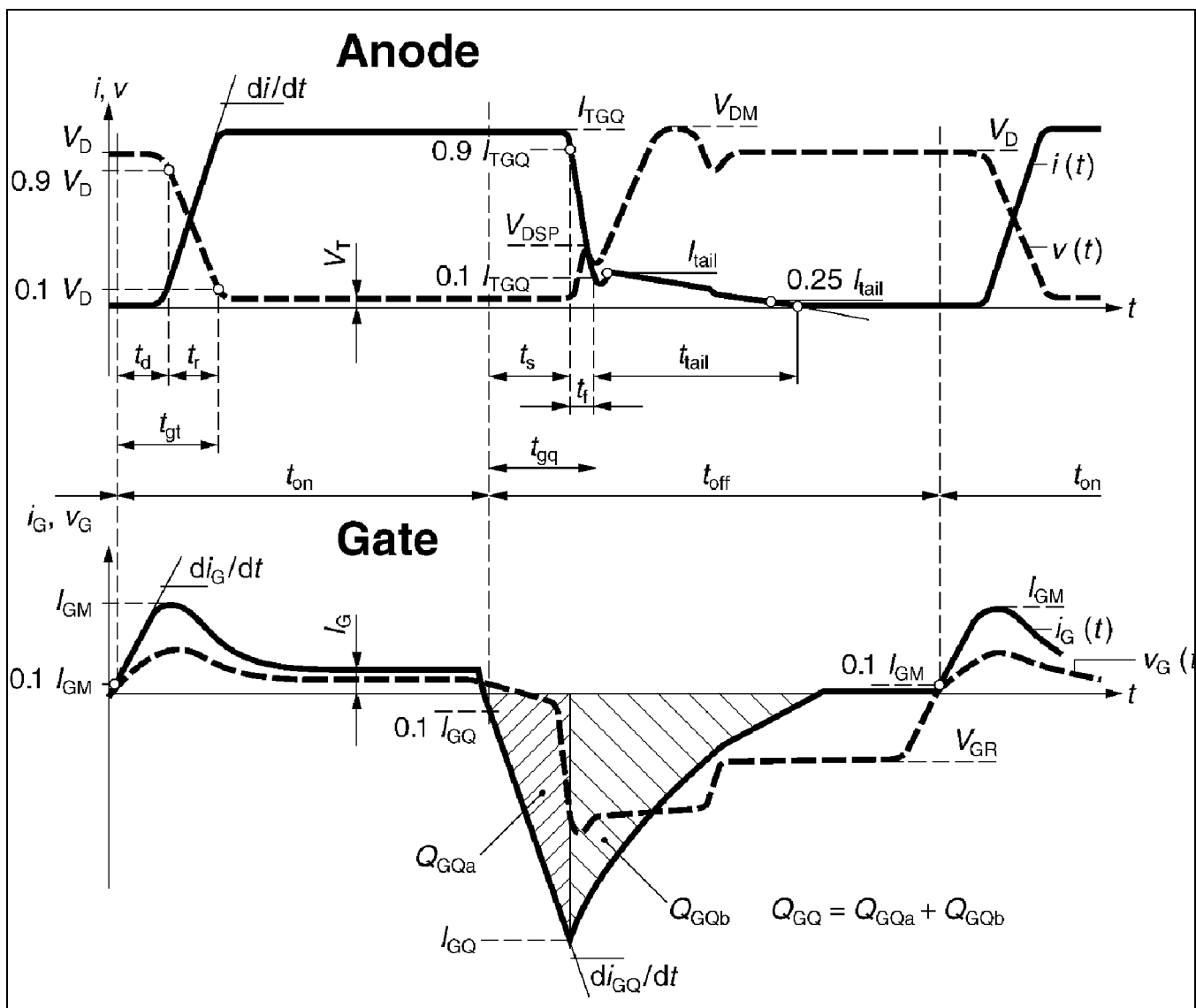
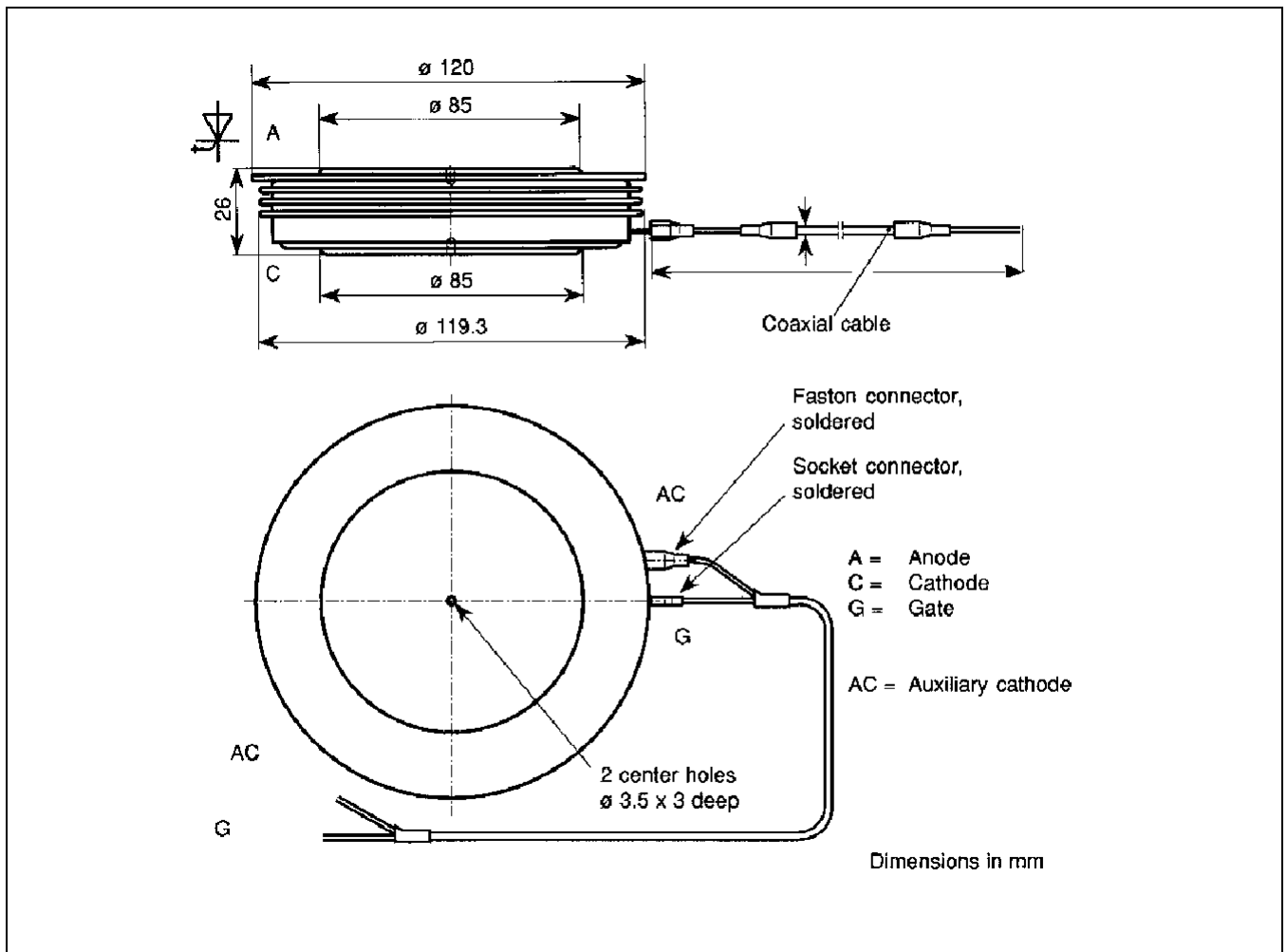


Fig. 18 General current and voltage waveforms with GTO-specific symbols.





**Fig. 19** Outline drawing. All dimensions are in millimeters and represent nominal values unless stated otherwise.

The 5SGF 40L4502 is a 91 mm buffered layer GTO with exceptionally low dynamic and static losses designed to retro-fit all former 4 kA GTOs of the same voltage. It offers optimal trade-off between on-state and switching losses and is encapsulated in an industry-standard press pack housing 120 mm wide and 26 mm thick.

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